## Notice of References Cited Application/Control No. 10/663,766 Examiner Art Unit Page 1 of 1 Applicant(s)/Patent Under Reexamination TAKUROH ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,510,886	04-1996	Sugimoto et al.	399/308
*	В	US-5,515,145	05-1996	Sasaki et al.	399/302
*	С	US-5,761,594	06-1998	Seto et al.	399/302
*	D	US-6,175,702	01-2001	Takeuchi et al.	399/101
*	Ε	US-6,269,228	07-2001	Kayahara et al.	399/37
*	F	US-2003/0035660	02-2003	Sugino et al.	399/111
*	G	US-2003/0175052	09-2003	Adachi et al.	399/265
	Η	US-			
	_	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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